

### OptiMOS™2 Small-Signal-Transistor

### **Features**

- N-channel
- Enhancement mode
- Ultra Logic level (1.8V rated)
- · Avalanche rated
- Qualified according to AEC Q101
- 100% lead-free; RoHS compliant
- Halogen-free according to IEC61249-2-21

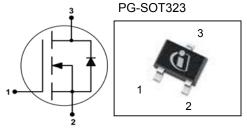






### **Product Summary**

V <sub>DS</sub>		20	V
R <sub>DS(on),max</sub>	160	mΩ	
	V <sub>GS</sub> =1.8 V	240	
I <sub>D</sub>	1.4	Α	



Туре	Package	Tape and Reel Information	Marking	Lead Free	Packing
BSS816NW	PG-SOT323	H6327: 3000 pcs/ reel	XCs	Yes	Non dry

### **Maximum ratings,** at $T_j$ =25 °C, unless otherwise specified

Parameter	Symbol	Conditions	Value	Unit
Continuous drain current	ID	T <sub>A</sub> =25 °C	1.4	А
		T <sub>A</sub> =70 °C	1.1	
Pulsed drain current	I <sub>D,pulse</sub>	T <sub>A</sub> =25 °C	5.6	
Avalanche energy, single pulse	E <sub>AS</sub>	/ <sub>D</sub> =1.4 A, R <sub>GS</sub> =25 Ω	3.7	mJ
Reverse diode dv/dt	dv/dt	I <sub>D</sub> =1.4 A, V <sub>DS</sub> =16 V, d <i>i</i> /d <i>t</i> =200 A/μs, T <sub>j,max</sub> =150 °C	6	kV/µs
Gate source voltage	$V_{GS}$		±8	V
Power dissipation <sup>1)</sup>	$P_{\text{tot}}$	T <sub>A</sub> =25 °C	0.5	W
Operating and storage temperature	$T_{\rm j},T_{\rm stg}$		-55 150	°C
ESD Class		JESD22-A114 -HBM	0 (<250V)	
Soldering Temperature			260 °C	
IEC climatic category; DIN IEC 68-1	_		55/150/56	



Parameter	Symbol Conditions	Values			Unit	
			min.	typ.	max.	
Thermal characteristics						
Thermal resistance, junction - ambient	$R_{ m thJA}$	minimal footprint 1)	-	-	250	K/W

### **Electrical characteristics,** at $T_{\rm j}$ =25 °C, unless otherwise specified

### Static characteristics

Drain-source breakdown voltage	V <sub>(BR)DSS</sub>	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 250 μA	20	-	-	V
Gate threshold voltage	$V_{\rm GS(th)}$	V <sub>DS</sub> =0 V, I <sub>D</sub> =3.7 μA	0.3	0.55	0.75	
Drain-source leakage current	I <sub>DSS</sub>	V <sub>DS</sub> =20 V, V <sub>GS</sub> =0 V, T <sub>j</sub> =25 °C	ı	1	1	μΑ
		V <sub>DS</sub> =20 V, V <sub>GS</sub> =0 V, T <sub>j</sub> =150 °C	ı	1	100	
Gate-source leakage current	I <sub>GSS</sub>	V <sub>GS</sub> =8 V, V <sub>DS</sub> =0 V	1	1	100	nA
Drain-source on-state resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> =1.8 V, I <sub>D</sub> =0.44 A	1	153	240	mΩ
		V <sub>GS</sub> =2.5 V, I <sub>D</sub> =1.4 A	ı	107	160	
Transconductance	$g_{ extsf{fs}}$	$ V_{\rm DS}  > 2 I_{\rm D} R_{\rm DS(on)max},$ $I_{\rm D} = 1.1 \text{ A}$		4.9	-	S

 $<sup>^{1)}</sup>$  Performed on  $40\text{mm}^2$  FR4 PCB. The traces are 1mm wide,  $70\mu\text{m}$  thick and 20mm long; they are present on both sides of the PCB.



Parameter	Symbol	mbol Conditions		Values		Unit
			min.	typ.	max.	
Dynamic characteristics						
Input capacitance	Ciss		-	126	180	pF
Output capacitance	Coss	$V_{\rm GS}$ =0 V, $V_{\rm DS}$ =10 V, f=1 MHz	-	47	67	
Reverse transfer capacitance	C <sub>rss</sub>	1	-	7	10	
Turn-on delay time	$t_{d(on)}$		-	5.3	-	ns
Rise time	t <sub>r</sub>	V <sub>DD</sub> =10 V, V <sub>GS</sub> =2.5 V,	-	9.0	-	
Turn-off delay time	$t_{d(off)}$	$I_{\rm D}$ =1.4 A, $R_{\rm G}$ =6 Ω	-	11	-	
Fall time	$t_{f}$	] [	-	2.2	-	
Gate Charge Characteristics		T		T	Γ	
Gate to source charge	Q <sub>gs</sub>	$V_{\rm DD}$ =10 V, $I_{\rm D}$ =1.4 A, $V_{\rm GS}$ =0 to 2.5 V	-	0.2	-	nC
Gate to drain charge	Q <sub>gd</sub>		-	0.2	-	
Gate charge total	$Q_g$		-	0.6	-	
Gate plateau voltage	$V_{\rm plateau}$		-	1.6	-	V
Reverse Diode						
Diode continous forward current	Is	T -25 °C	-	-	0.5	Α
Diode pulse current	I <sub>S,pulse</sub>	- T <sub>A</sub> =25 °C	-	-	6	
Diode forward voltage	V <sub>SD</sub>	V <sub>GS</sub> =0 V, I <sub>F</sub> =1.4 A, T <sub>j</sub> =25 °C	-	0.87	1.1	V
Reverse recovery time	t <sub>rr</sub>	V <sub>R</sub> =10 V, I <sub>F</sub> =1.4 A,	-	8.1	-	ns
Reverse recovery charge	Q <sub>rr</sub>	d <i>i</i> <sub>F</sub> /d <i>t</i> =100 A/μs	-	1.4	-	nC



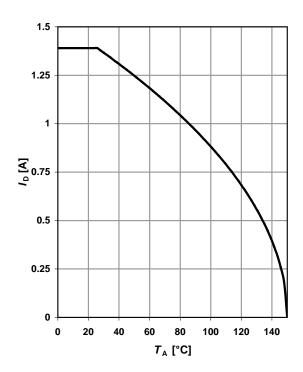
### 1 Power dissipation

$$P_{tot}$$
=f( $T_A$ )

# 0.375 2 0.25 0.125 0 40 80 120 T<sub>A</sub> [°C]

### 2 Drain current

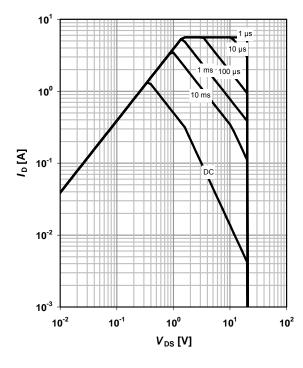
$$I_D = f(T_A); V_{GS} \ge 2.5 \text{ V}$$



### 3 Safe operating area

$$I_{\rm D}$$
=f( $V_{\rm DS}$ );  $T_{\rm A}$ =25 °C;  $D$ =0

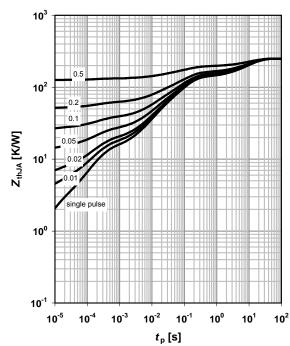
parameter:  $t_{\rm p}$ 



### 4 Max. transient thermal impedance

$$Z_{thJA}$$
=f( $t_p$ )

parameter:  $D=t_p/T$ 

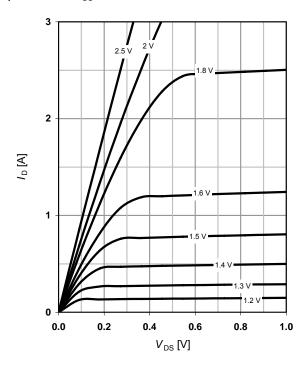




### 5 Typ. output characteristics

 $I_D = f(V_{DS}); T_j = 25 °C$ 

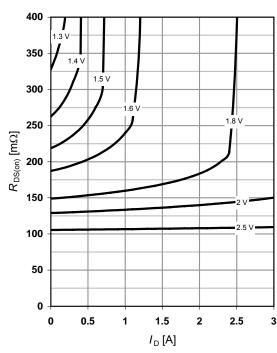
parameter:  $V_{\rm GS}$ 



### 6 Typ. drain-source on resistance

 $R_{DS(on)}$ =f( $I_D$ );  $T_j$ =25 °C

parameter: V<sub>GS</sub>

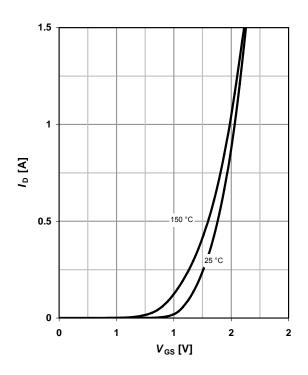


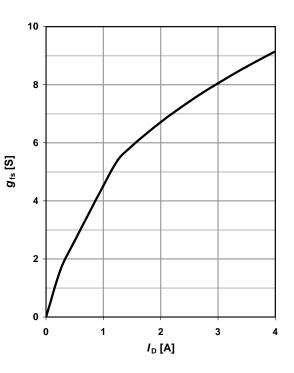
### 7 Typ. transfer characteristics

 $I_{D}$ =f( $V_{GS}$ );  $|V_{DS}|$ >2 $|I_{D}|R_{DS(on)max}$ 

### 8 Typ. forward transconductance

$$g_{fs}$$
=f( $I_D$ );  $T_j$ =25 °C

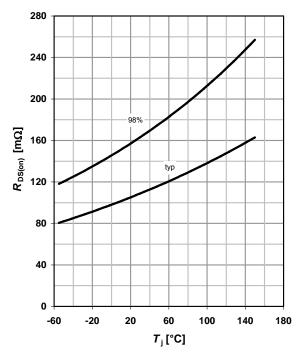






### 9 Drain-source on-state resistance

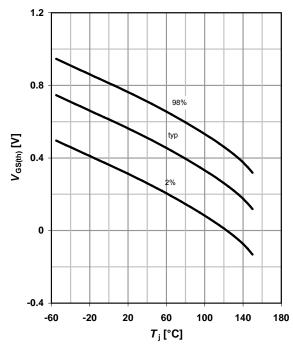
$$R_{DS(on)}$$
=f( $T_j$ );  $I_D$ =1.4 A;  $V_{GS}$ =2.5 V



### 10 Typ. gate threshold voltage

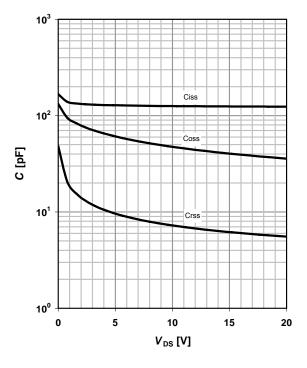
$$V_{GS(th)}$$
=f( $T_j$ );  $V_{DS}$ = $V_{GS}$ ;  $I_D$ =3.7  $\mu$ A

parameter:  $I_D$ 



### 11 Typ. capacitances

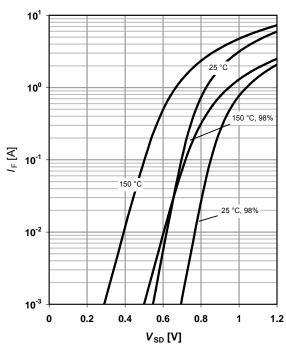
 $C=f(V_{DS}); V_{GS}=0 V; f=1 MHz; T_j=25$ °C



### 12 Forward characteristics of reverse diode

$$I_{\mathsf{F}} = \mathsf{f}(V_{\mathsf{SD}})$$

parameter:  $T_{\rm j}$ 

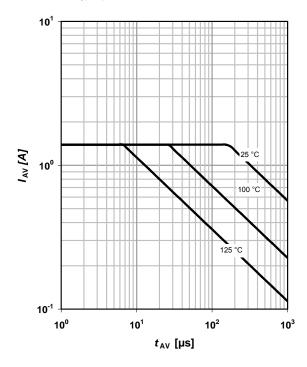




### 13 Avalanche characteristics

 $I_{\mathsf{AS}}$ =f( $t_{\mathsf{AV}}$ );  $R_{\mathsf{GS}}$ =25  $\Omega$ 

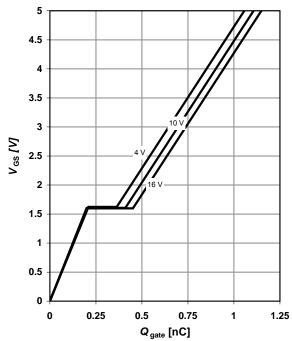
parameter:  $T_{j(start)}$ 



### 14 Typ. gate charge

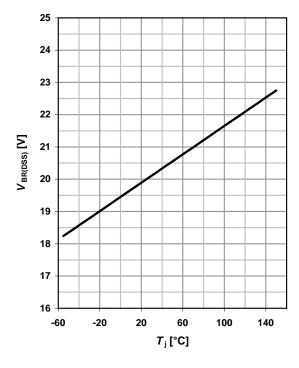
 $V_{\rm GS}$ =f(Q<sub>gate</sub>);  $I_{\rm D}$ =1.4 A pulsed

parameter:  $V_{\rm DD}$ 

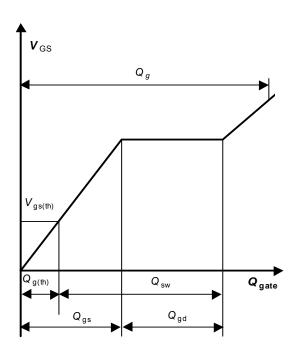


### 15 Drain-source breakdown voltage

 $V_{BR(DSS)}$ =f( $T_i$ );  $I_D$ =250  $\mu$ A



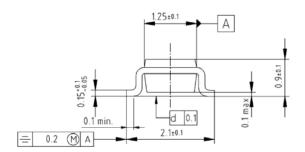
### 16 Gate charge waveforms

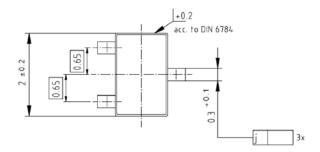




### **SOT323**

### Package Outline:

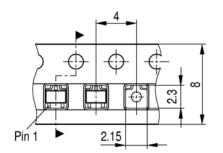




Packaging:

### **Footprint:**

## Reflow soldering Wave soldering To the soldering solde





Dimensions in mm



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